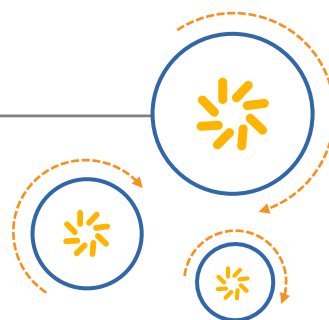




Qualcomm Atheros, Inc.



QCA4004 Low-Energy Wi-Fi Dual-Band 802.11a/b/g/n SoC

Device Specification

80-Y7545-6 Rev. D

January 7, 2015

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Revision history

Revision	Date	Description
A	April 2014	Initial release. For regular distribution as part of PDK.
B	September 2014	■ Global change: Converted the data sheet to device specification. The content movings below are not marked with change bar. □ Moved functional description to Section 1.5 through Section 1.15. □ Moved voltage regulator and bootstrap mode to Section 1.16 and Section 1.17. □ Moved package dimensions, ordering information, and thermal characteristics to Chapter 4. □ Moved power sequence to Section 3.3 and clock/timing to Section 3.5. ■ Section 1.1, Section 1.4: Added document overview and special marks. ■ Section 1.15: Added DNS, SNTP, bridging/routing, and raw socket support. ■ Chapter 4: Added the Mechanical information chapter. ■ Section 4.1: Updated the package drawing and dimensions according to NT90-Y5242-1. ■ Section 4.3: Updated ordering number for chip revision B. ■ Chapter 5: Added Carrier, Storage, and Handling Information. ■ Chapter 6: Added PCB Mounting Guidelines. ■ Chapter 7: Added chip reliability data.
C	October 2014	Table 3-2: Corrected the chip case temperature for industrial part.
D	January 2015	Cover page: Replaced the cover with new branding and legal statements. Table 3-1 : Deleted legacy ESD-HBM, ESD-CDM, ESD-CDM-RF rows.

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1 Introduction

1.1 Document overview

Technical information for the QCA4004 is primarily covered by the documents listed in [Table 1-1](#). Each is a self-contained document, but a thorough understanding of the device and its applications requires familiarization with all of them. The device description in is a good place to start.

Table 1-1 Primary QCA4004 documentation

Document No.	Title/Description
80-Y7545-6 (this document)	QCA4004 Low-Energy Wi-Fi Dual-Band 802.11a/b/g/n SoC Device Specification Conveys all QCA4004 IC electrical and mechanical specifications. Additional material includes pin assignments; shipping, storage, and handling instructions; PCB mounting guidelines; and part reliability. This document can be used by company purchasing departments to facilitate procurement.

The QCA4004 Low-Energy Wi-Fi Dual-Band 802.11a/b/g/n SoC Device Specification is organized as follows:

- [Chapter 1](#) Gives a high-level functional description of the device, lists the device features, and defines marking conventions, terms, and acronyms used throughout this document.
- [Chapter 2](#) Defines the device pin assignments.
- [Chapter 3](#) Defines the device electrical characteristics, including absolute maximum ratings and recommended operating conditions.
- [Chapter 4](#) Provides IC mechanical information, including dimensions, markings, ordering information, moisture sensitivity, and thermal characteristics.
- [Chapter 5](#) Describes carrier, storage and handing information of the QCA4004 device.
- [Chapter 6](#) Presents procedures and specifications for mounting the QCA4004 device onto printed circuit boards (PCBs).
- [Chapter 7](#) Presents the QCA4004 device reliability data, including a definition of the qualification samples and a summary of qualification test results.

1.2 QCA4004 device description

The QCA4004 is an intelligent platform for the Internet of Everything that contains a low-power Wi-Fi connectivity solution on a single chip. It includes a number of TCP/IP-based connectivity protocols along with SSL, enabling a low-cost, low-complexity system to obtain full-featured internet connectivity and reliable information exchange.

The QCA4004 provides two interfaces for connecting to local system controllers. A UART-based host interface can be used for rapid development and deployment of simple data streams between the local device and the internet cloud. An SPI slave interface is available for applications that require more advanced connectivity to the network.

The QCA4004 Wi-Fi link is a full-featured, dual-band, single stream 802.11n solution. The Wi-Fi link is highly integrated, and includes an energy efficient on-board power amplifier and LNA. For the 2.4 GHz band, RF switches are also integrated. The QCA4004 Wi-Fi link is optimized for low system cost, and minimizes the number and cost of any components required to achieve a reliable Wi-Fi link.

1.3 Product features

Wi-Fi link

- Support for IEEE 802.11a/b/g/n
- Single stream 1×1
- Dual-band 2.4 GHz/5 GHz
- Integrated PA, LNA, with support for external PA and external LNA
- Single or dual Rx front end for antenna diversity
- Green Tx power saving mode
- Low power listen mode
- Data rates up to 150 Mbps
- Full security support: WPS, WPA, WPA2, WAPI, WEP, TKIP

System cost optimization

- Highly-Integrated Wi-Fi solution that requires only a single crystal, antenna, and antenna matching components to complete the RF link.
- Integrated IPv4/IPv6 TCP/IP stack
- Integrated Network services such as HTTP, DNS, FTP
- 8 mm x 8 mm, 68-pin QFN package
- QCA4004 patch firmware is stored and automatically loaded from a low cost serial flash memory

Manufacturing interface

- USB 2.0 device interface, providing a simplified, high-speed, and scalable manufacturing test and configuration interface for QCA4004-based systems

Host interfaces

- SPI slave interface
Allows for simplified connection to local host microcontrollers.
Host driver source code and programming APIs are available.
- UART/SPI host interface allows simple interfacing to microcontrollers.
- UART with an AT style command set

Wakeup manager

- Non-volatile 8 KB RAM
- Suspend/resume timer

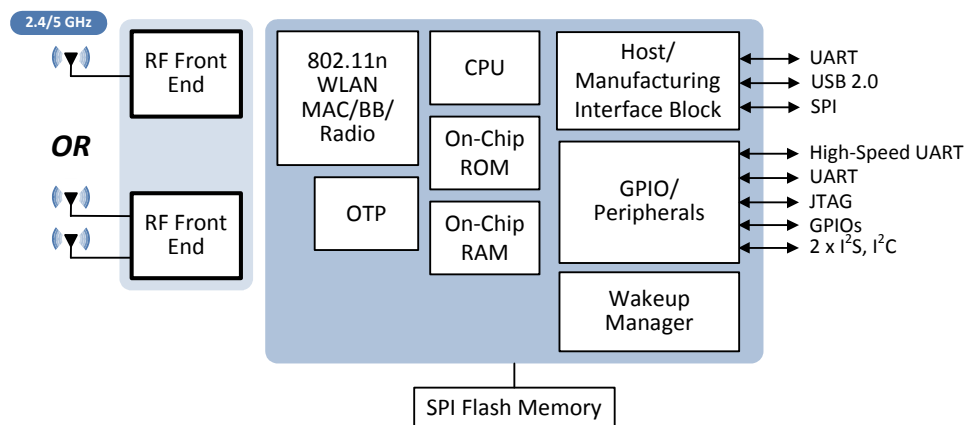


Figure 1-1 QCA4004 functional block diagram

1.4 Special marks

Table 1-2 defines special marks used in this document.

Table 1-2 Special marks

Mark	Definition
[]	Brackets ([]) sometimes follow a pin, register, or bit name. These brackets enclose a range of numbers. For example, SDC1_DATA[7:4] may indicate a range that is 4 bits in length, or DATA[7:0] may refer to all eight DATA pins.
_N	A suffix of _N indicates an active low signal. For example, RESIN_N.

Table 1-2 Special marks

Mark	Definition
0x000	Hexadecimal numbers are identified with an x in the number (for example, 0x0000). All numbers are decimal (base 10) unless otherwise specified. Non-obvious binary numbers have the term binary enclosed in parentheses at the end of the number; for example, 0011 (binary).
	A blue vertical bar in the outside margin of a page indicates that a change was made since the previous revision of this document.

1.5 Integrated network processor

The QCA4004 includes a network processor that provides IP services and manages Wi-Fi link operations. The network processor code is loaded automatically from ROM off-chip serial flash memory. The flash memory is also used to store system configuration and persistent data sets. The network processor is optimized for energy efficient communications and includes multiple power states (see [Section 1.8](#)). Customers can use the integrated network processor to implement application-specific solutions. This customized code is stored on an off-chip serial flash.

1.6 Serial interface

The QCA4004 includes two high-speed Universal Asynchronous Receiver/Transmitter (UART) interfaces, which may be configured to serve as either a host interface link or a debug message console.

1.7 Reset and startup sequence

The QCA4004 CHIP_PWD_L pin can be used to completely reset the entire chip. After this signal has been de-asserted, if configured for SPI slave operation, the QCA4004 waits in a low-power state until communication from the host, indicating that the Wi-Fi and the network services should be started. When configured for UART host mode, the QCA4004 begins its boot up process and starts network services as soon as CHIP_PWD_L is de-asserted.

1.7.1 Wakeup manager

The wakeup manager enables use of the QCA4004 in low power environments with no external host CPU. To achieve the lowest average power profile, the QCA4004 must be placed in suspend mode for the majority of the time. While in suspend state, the QCA4004 shuts down all circuits except a few critical blocks needed to resume operation after suspend; these include I/O pads to detect a wakeup request, a sleep timer to detect a synchronous wakeup event, and a small RAM that stores state information spanning a suspend-resume cycle.

To enter SUSPEND state, QCA4004 firmware saves state in the on-chip non-volatile RAM (NVRAM) and configures wakeup timers. Firmware then triggers the suspend operation, which turns on isolation circuits and turns off voltage regulators to the QCA4004 main core block.

Only the wakeup manager block and PMU circuits remain powered in suspend mode. When a wakeup event is detected, the device exits suspend back to active state. Wakeup events include synchronous wakeup, which occurs when the sleep timer in the wakeup manager expires, and asynchronous wakeup, which occurs when a pin event is detected on the wakeup pin.

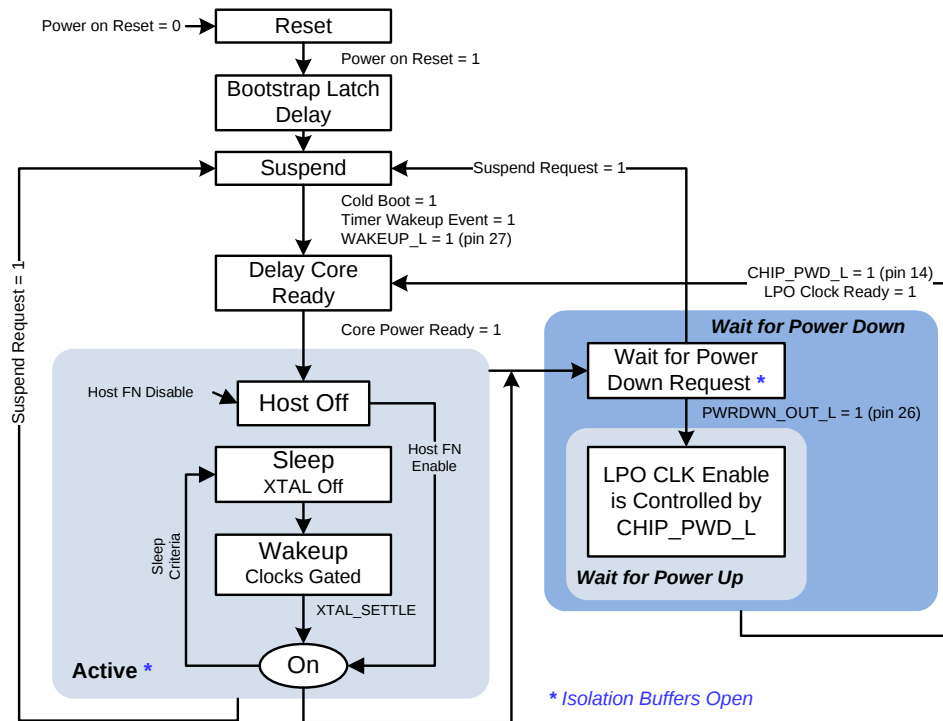


Figure 1-2 Wakeup manager

1.7.2 Detailed SPI slave startup sequence

After a COLD_RESET event (e.g., the host toggles CHIP_PWD_L), the QCA4004 enters the HOST_OFF state and awaits communication from the host indicating that Wi-Fi and network services should be started. When configured for UART host mode, the QCA4004 begins its boot up process and starts network services as soon as CHIP_PWD_L pin is de-asserted.

- When the host is ready to use the QCA4004, it initiates communication via SPI slave and enables network services by writing to a specific register via the SPI slave interface.
- When the QCA4004 enters the WAKEUP state for some duration and transits to the ON state, the on-chip network processor configures the QCA4004 functions and interfaces, as per the configuration and customization data set provided by the serial flash memory. When the QCA4004 is ready to receive commands from the host, it sets a specific flag that is accessible from the Host CPU via the SPI slave interface.
- The host reads the ready bit and can now send function commands to the QCA4004.

1.7.3 Power management unit

The QCA4004 has an integrated power management unit (PMU) that generates all the power supplies required by its internal circuitry either from an external battery or a 3.3 V supply.

The main components of the PMU include:

- A switching regulator (SWREG) that produces a 1.2 V supply from the 3.3 V supply.
- A linear regulator (SREG) which converts the host I/O supply to a 1.2 V supply for some small control blocks which are turned on when CHIP_PWD_L is de-asserted.
- A linear regulator which produces a 1.2 V supply from a 3.3 V supply (can be used instead of the SWREG to reduce the BOM cost).

1.8 Power transition

The QCA4004 provides integrated power management and control functions and extremely low power operation for maximum battery life across all operational states by:

- Gating clocks for logic when not needed
- Shutting down unneeded high speed clock sources
- Reducing voltage levels to specific blocks in some states

1.8.1 Sleep state management

SLEEP state minimizes power consumption while network services are not required, yet the system must remain ready for use within a short time. In SLEEP state, all high speed clocks are gated off and the external reference clock source is powered off. The network processor and Wi-Fi link are also suspended and not operational. All state information in the network processor (and its memory) and the Wi-Fi link are preserved to allow a fast resume to full network services.

The system remains in sleep state until a wakeup event causes the system to enter the WAKEUP state. Once WAKEUP state is entered, the QCA4004 restores all voltage levels and clocks, then automatically moves to the ON state. This wakeup event can be either a pin event or internal timer based event. The pin event may be triggered by the host CPU, or some system level event.

1.8.2 Hardware power states

Table 1-3 describes the top level hardware power states in the QCA4004.

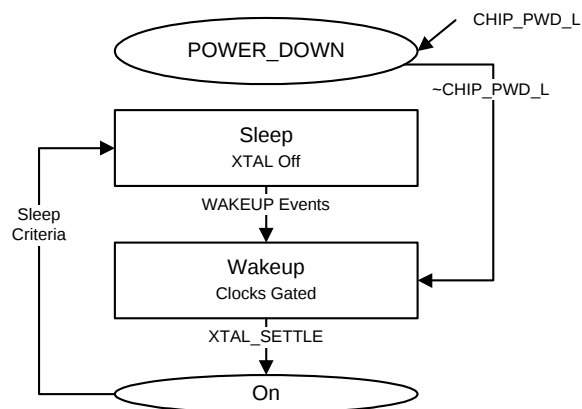
Table 1-3 Power management states

State	Description
POWER_DOWN	CHIP_PWD_L pin assertion immediately brings the chip to this state.
	Sleep clock is disabled.
	No state is preserved.
SUSPEND	While in suspend state, the chip shuts down all circuits except a few critical blocks needed to resume operation after suspend.

Table 1-3 Power management states

State	Description
HOST_OFF	Network services and WLAN are off. Only the SPI host interface is powered on, the rest of the chip is power gated (off).
	The host can transition QCA4004 to WAKEUP (followed by ON) at any time by writing a register in the host interface domain.
	WLAN and CPU states are not retained.
	For UART hosted, or USB manufacturing configurations, this state is bypassed by pulling GPIO0 low at the de-assertion of CHIP_PWD_L. This state applies only to SPI designs.
SLEEP	Only the sleep clock is operating.
	The crystal or oscillator is disabled.
	Any wakeup events (MAC, host, LF timer, GPIO interrupt force a transition to WAKEUP.
	All internal states are maintained.
	Host interface is idle (USB is in SUSPEND).
WAKEUP	The system transition from sleep OFF states to ON.
	The high frequency clock is gated off as the oscillator is brought up and the PLL is enabled.
	WAKEUP duration is less than 2 ms.
ON	The high speed clock is operational.
	Lower-level clock gating is implemented at the block level, including the CPU, which can be gated off using WAITI instructions while the system is on.

Figure 1-3 depicts the USB and UART power state transition diagrams.

**Figure 1-3 QCA4004 Power State: USB and UART Host Modes or Hostless Systems**

1.9 System clocking (RTC block)

The QCA4004 has an RTC block which controls the clocks and power going to other internal modules. Its inputs consist of sleep requests from these modules and its outputs consist of clock enable and power signals which are used to gate the clocks going to these modules. The RTC block also manages resets going to other modules with the device. The QCA4004's clocking is grouped into two types:

- High-speed
- Low-speed

1.9.1 High speed clocking

The reference clock source drives the PLL and RF synthesizer within the QCA4004. It can be either an external crystal or oscillator. To minimize power consumption, the reference clock source is powered off in SLEEP, HOST_OFF, POWER_DOWN and after HOST_OFF states. For an external crystal, the QCA4004 disables the on-chip oscillator driver. For an external oscillator, the QCA4004 de-asserts its CLK_REQ signal to indicate that a reference clock is not needed.

When exiting SLEEP state, the QCA4004 waits in WAKEUP state for a programmable duration. During this time, the CLK_REQ signal is asserted to allow for the reference clock source to settle. The CLK_REQ signal remains asserted in ON state.

The QCA4004 supports reference clock sharing in all power states. For an external crystal, the on-chip oscillator driver drives a reference clock output whenever an external clock request signal is asserted. For an external oscillator, the external clock request signal is forwarded on the CLK_REQ signal, and the input clock is passed along to the reference clock output.

1.9.2 Low-speed clocking

The QCA4004 has eliminated the need for an external sleep clock source thereby reducing system cost. Instead, an internal ring oscillator is used to generate a low frequency sleep clock. It is also used to run the state machines and counters related to low power states.

The QCA4004 has an internal calibration module which produces a 32.768 KHz output with minimal variation. For this, it uses the reference clock source as the golden clock. As a result, the calibration module adjusts for process and temperature variations in the ring oscillator when the system is in ON state.

1.9.3 Interface clock

The host interface clock represents another clock domain for the QCA4004. This clock comes from the host and is completely independent from the other internal clocks. It drives the host interface logic as well as certain registers which can be accessed by the host in HOST_OFF and SLEEP states.

1.9.4 Wakeup manager clock

The QCA4004 includes a dedicated always-on clock oscillator. In the SUSPEND state, this clock oscillator is the only clock that continues to run. This clock is used to calculate the resume from SUSPEND time interval. The QCA4004 has an option for using an external 32-KHz oscillator instead of the onboard low-power oscillator.

1.10 MAC block

The QCA4004 Wireless MAC consists of these major blocks:

- Host interface unit (HIU) for bridging to the AHB for bulk data accesses and APB for register accesses
- 10 queue control units (QCU) for transferring Tx data
- 10 DCF control units (DCU) for managing channel access
- Protocol control unit (PCU) for interfacing to baseband
- DMA receive unit (DRU) for transferring Rx data
- Supports Rx diversity

1.11 Baseband block

The QCA4004 baseband (BB) module is the physical layer controller for the 1x1 802.11a/b/g/n air interface. It is responsible for modulating data packets in the transmit direction, and detecting and demodulating data packets in the receive direction. It has a direct control interface to the radio to enable hardware to adjust analog gains and modes dynamically.

1.12 Active power save

1.12.1 Low Power Listen (LPL)

To minimize active current consumption, the QCA4004 firmware will set the receiver in a low power listen mode, thus saving active power in between frames, when the transceiver is awaiting frames, as well as during active reception. It can be enabled in most conditions with minimal performance impact, between 1 and 2 dB. If harsh channel conditions require it, firmware will automatically revert to full power mode.

1.12.2 Green Tx

To minimize active current consumption during transmission, the QCA4004 will utilize Green Tx. This feature allows the device to save power when communicating with a nearby station or access point when high output power is not required to sustain reliable communications. In such cases, the transmitter will reduce the transmit power to obtain current saving, while maintaining its high uplink throughput.

1.13 IPv4/IPv6 networking

The QCA4004 includes a TCP/IP and UDP offload capability. This capability can reduce Flash requirements on a host MCU by up to 100 KBytes and also free up CPU cycles. The IP stack is a simultaneous IPv4/IPv6 stack with a BSD-like interface to simplify porting and integration with

common embedded operating systems. The supported features of the QCA4004 (support for DHCP, multicast, and ARP) include:

- ARP
- Forwarding
- Fragmentation/reassembly (supported with limitation)
- IPv4/v6 header processing
- UDP/TCP socket support
- DHCP v4
- Neighbor discovery
- Broadcast/multicast
- Address auto-configuration
- Multicast
- TCP zero-copy feature
- HTTP/SSL client/server feature
- DNS proxy server and client
- SNTP client
- Bridging/Routing
- Raw sockets

The QCA4004 supports many key IPv4 and IPv6 RFCs as shown in [Table 1-4](#) and [Table 1-5](#).

Table 1-4 QCA4004 IPv4 supported RFCs

IPv4 RFC Number
RFC1122: TCP Timeout/retransmission
RFC1122: TCP Keep-alive
RFC1122: TCP Zero-Window-Probe
RFC1122: TCP Sliding window protocol

Table 1-5 QCA4004 IPv6 supported RFCs

IPv6 RFC Number
RFC2464: Transmission of IPv6 packets over Ethernet networks
RFC2460: Internet Protocol version 6
RFC2462: Duplicate Address Detection (DAD)
RFC2463: ICMPv6
RFC3513: IP version 6 addressing architecture
RFC3484: Default Address Selection
RFC2461: Neighbor discovery for IPv6 host
RFC4862: Stateless Address Auto-configuration

1.14 Internal voltage regulator

The QCA4004 supports two regulator modes for its on-chip 1.2 V regulator; see [Section 1.15.4](#) for more information.

1.14.1 Switching 1.2 V regulator

[Figure 1-4](#) depicts the switching 1.2 V switching power supply regulated by the QCA4004. Refer to the reference design schematics for details.

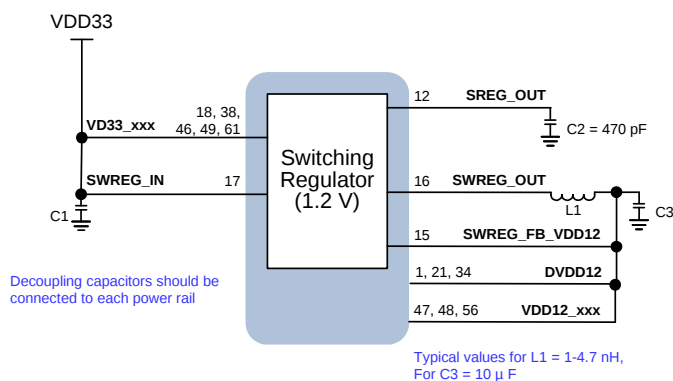


Figure 1-4 1.2 V switching power supply regulated by the QCA4004

1.14.2 Linear 1.2 V regulator

[Figure 1-5](#) depicts the switching 1.2 V linear power supply regulated by the QCA4004. Refer to the reference design schematics for details.

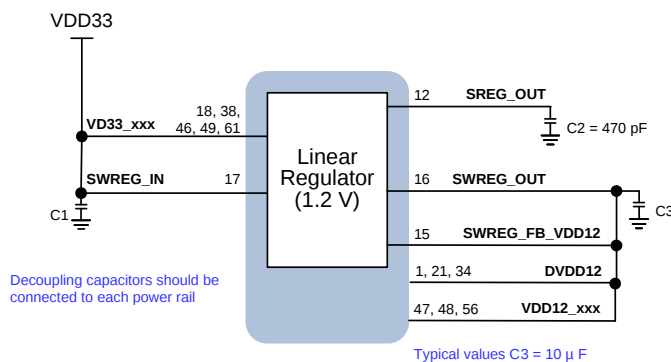


Figure 1-5 1.2 V linear power supply regulated by the QCA4004

1.15 Bootstrap modes and pins

Certain pins in the QCA4004 are sampled at startup, and these sampled values are used to select among various bootstrap modes and chip configurations.

1.15.1 Internal bias

Table 1-6 shows the pins biased by chip hardware during power down. After startup, chip firmware may change the bias.

Table 1-6 Internal bias during power down

GPIO	Internal bias
GPIO6	Pull-Down
GPIO11	
GPIO20	Pull-Up
GPIO30	
GPIO31	

1.15.2 Host mode configuration

Table 1-7 lists the QCA4004 bootstrap pins that select the interface used to communicate with the external host CPU. Host mode selection affects pin behavior of host interface pins as well as bootup processes in the PCM state machine. It informs the QCA4004 about the presence of an external CPU (referred to as the host controller) and the interface used to exchange messages.

Table 1-7 Host mode configuration

Pin name	Bootstrap function name	On chip biasing	GPIO [0,2]	Description
GPIO0, GPIO2	hostmode	—	00	QCA4004 CPU bootup is under control of the host CPU via the USB interface. The external CPU is required and the host interface is USB.
			01	No host required at startup time. The QCA4004 CPU self boots and firmware may configure any of the available interfaces. No external CPU is required.
			10	The QCA4004 CPU bootup is under control of host CPU via SPI Slave interface. The external CPU is required and the SPI interface is the host interface.
			11	Reserved

1.15.3 Crystal value configuration

Table 1-8 shows the bootstrap pin to configure the crystal value.

Table 1-8 Crystal value configuration

Pin name	Bootstrap function name	On chip biasing	Description	
GPIO20	xtal_freq[0]	—	0	Reserved
			1	40 MHz

1.15.4 1.2 V regulator configuration

The QCA4004 supports two regulator modes for its on-chip 1.2 V regulator: switching and linear. Linear mode requires fewer board-level components, but at a slightly higher power consumption than switching mode. [Table 1-9](#) shows the bootstrap pin to configure the 1.2 V regulator.

Table 1-9 1.2 V regulator configuration

Pin name	Bootstrap function name	On chip biasing	Description	
GPIO13	en_linear	—	0	Switching regulator
			1	Linear regulator

1.15.5 1.8 V regulator configuration

The QCA4004 supports a regulator mode for its on-chip 1.8 V regulator.

Table 1-10 1.8 V regulator Configuration

Pin name	Bootstrap function name	On chip biasing	Description	
GPIO31	1p8_reg_enable	Pull Up	Enable for on chip 1.8 V regulator	
			0	1.8 V regulator is disabled
			1	1.8 V regulator is enabled

2 Pin Descriptions

The QCA4004 device is available in the 68-pin QFN that includes several ground pins for electrical grounding, mechanical strength, and thermal continuity. See [Chapter 4](#) for package details. A high-level view of the pin assignments is shown in [Figure 2-1](#).

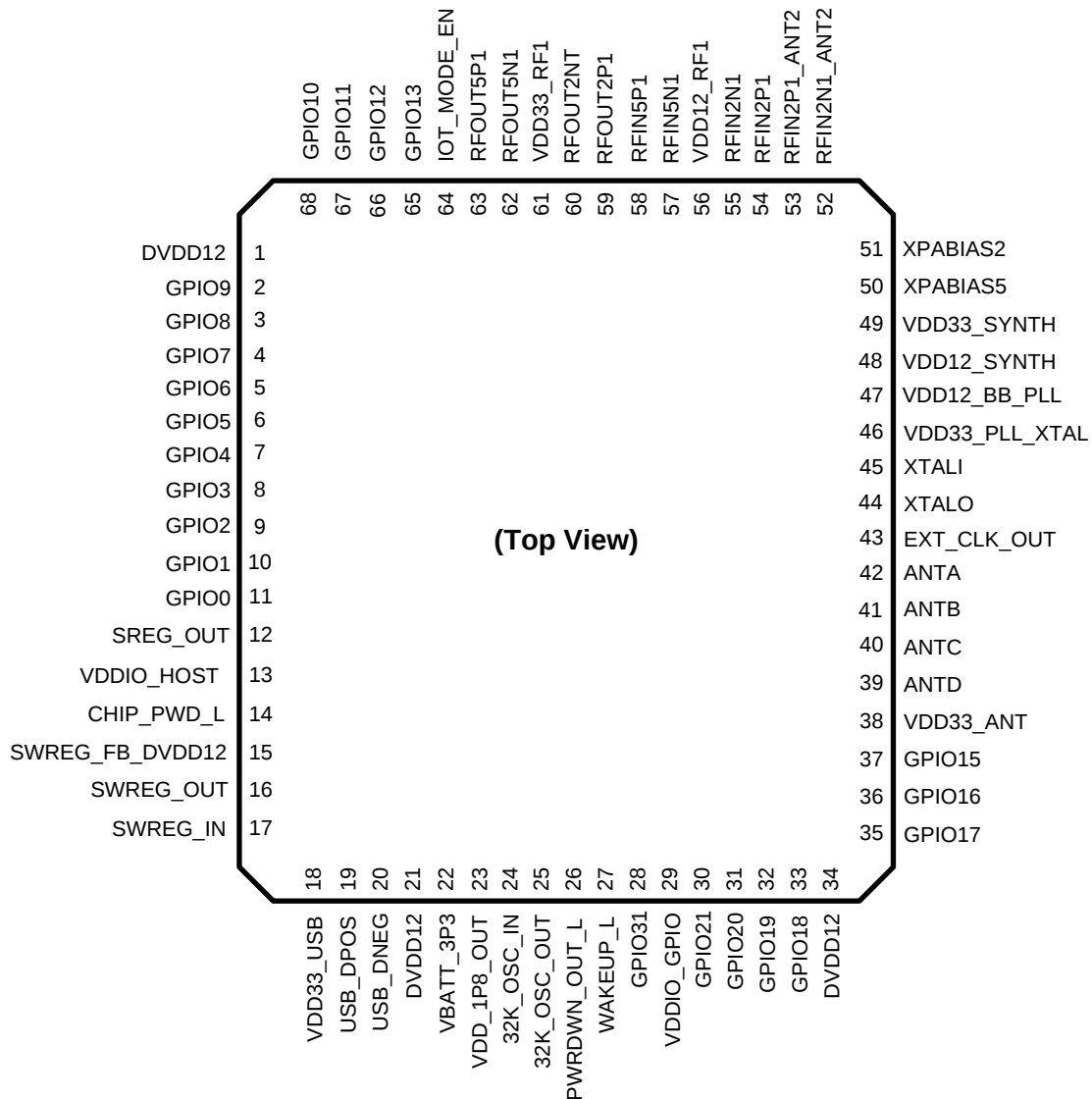


Figure 2-1 QCA4004 pin assignments (top view)

2.1 I/O parameter definitions

The following nomenclature is used for signal names:

NC/Reserved	No connection should be made to this pin
_L	At the end of the signal name, indicates active low signals
P	At the end of the signal name, indicates the positive side of a differential signal
N	At the end of the signal name indicates the negative side of a differential signal

The following nomenclature is used for signal types:

IA	Analog input signal
I	Digital input signal
IH	Input signals with weak internal pull-up, to prevent signals from floating when left open
IL	Input signals with weak internal pull-down, to prevent signals from floating when left open
I/O	A digital bidirectional signal
OA	An analog output signal
O	A digital output signal
P	A power or ground signal

Table 2-1 Pin description

Signal Name	Pin	Type	Description
General			
EXT_CLK_OUT	43	O	External clock out: 40 or 26 MHz; its corresponding half rate is available when configured.
XTALI	45	I/O	Supports 40 MHz or 26 MHz crystal. When an external reference clock is used, connect the clock signal to the XTALO pin and ground the XTALI pin.
XTALO	44	I	
Radio			
CHIP_PWD_L	14	I	Chip power-down control
RFIN2N1	55	IA	The first differential RF inputs
RFIN2P1	54	IA	
RFIN5N1	57	IA	
RFIN5P1	58	IA	

Table 2-1 Pin description (cont.)

Signal Name	Pin	Type	Description
RFOUT2N1	60	OA	The first differential RF outputs
RFOUT2P1	59	OA	
RFOUT5N1	62	OA	
RFOUT5P1	63	OA	
RFIN2P1_ANT2	53	IA	The second differential RF inputs for 2.4 GHz Rx/LNA diversity using two antennas; can be left open if not in use
RFIN2N1_ANT2	52	IA	
Analog Interface			
XPABIAS2	51	OA	Bias for optional external power amplifier in 2.4 GHz
XPABIAS5	50	OA	Bias for optional external power amplifier in 5 GHz
External Switch Control			
ANTA	42	O	External RF switch control
ANTB	41	O	
ANTC	40	O	
ANTD	39	O	
USB			
USB_DPOS	19	IA/OA	USB D+ signal; carries USB data to and from the USB 2.0 PHY
USB_DNEG	20	IA/OA	USB D- signal; carries USB data to and from the USB 2.0 PHY
Internal Switching Regulator			
SREG_OUT	12	P	1.2 V regulator output, connect to a 470 pF bypass capacitor on the board
SWREG_OUT	16	P	Output of the switching regulator to an LC filter or the LDO
SWREG_IN	17	P	3.3 V input to the internal switching regulator or LDO
Wakeup Manager			
IOT_MODE_EN	64	I	Power island isolation setting. This pin should be tied to the VBATT_3P3 signal. When this pin is low, the internal signal connections between pins 23 through 28 are isolated from rest of the chip. When this pin is high, internal connections are enabled, and pins 23 through 28 can be used.
32K_OSC_IN	24	IA	32 KHz crystal oscillator input
32K_OSC_OUT	25	OA	32 KHz crystal oscillator output
PWRDWN_OUT_L	26	O	Suspend Control signal. This pin is driven low by the QCA4004 when the wakeup manager power island is requesting a power down of the top level power island (SUSPEND state). This pin is driven high by the QCA4004 when the wakeup manager power island is requesting a resume to active to the top level power island.
WAKEUP_L	27	I	Wakeup Control. While in SUSPEND state, the QCA4004 monitors this pin, and if a falling edge or rising edge is detected, the resume from SUSPEND sequence is started.

Table 2-1 Pin description (cont.)

Signal Name	Pin	Type	Description
GPIO			
GPIO0	11	I/O	General purpose input/output. The QCA4004 supports a USB interface as well as an RGMII interface. The QCA4004 can be configured to support any of these interfaces by tying certain inputs externally.
GPIO1	10	I/O	
GPIO2	9	I/O	
GPIO3	8	I/O	
GPIO4	7	I/O	
GPIO5	6	I/O	
GPIO6	5	I/O	
GPIO7	4	I/O	
GPIO8	3	I/O	
GPIO9	2	I/O	
GPIO10	68	I/O	
GPIO11	67	I/O	
GPIO12	66	I/O	
GPIO13	65	I/O	
GPIO15	37	I/O	
GPIO16	36	I/O	
GPIO17	35	I/O	
GPIO18	33	I/O	
GPIO19	32	I/O	
GPIO20	31	I/O	
GPIO21	30	I/O	
GPIO31	28	I/O	
DVDD12	1, 21, 34	P	Digital 1.2 V power supply, should be connected to the SWREG_FB pin.
SWREG_FB_DVDD12	15	P	Reference feedback voltage to the internal switching regulator or LDO
VBATT_3P3	22	P	Connect to 3.3 V host IO supply
VDD_1P8_OUT	23	P	1.8 V LDO output, connect to a > 1 μ F bypass capacitor on the board
VDD12_BB_PLL	47	P	Analog 1.2 V power supply, should be connected to the SWREG_FB pin.
VDD12_RF1	56	P	
VDD12_SYNT	48	P	

Table 2-1 Pin description (cont.)

Signal Name	Pin	Type	Description
VDD33_ANT	38	P	Analog 3.3 V power supply
VDD33_RF1	61	P	
VDD33_PLL_XTAL	46	P	
VDD33_SYNT	49	P	
VDD33_USB	18	P	
VDDIO_HOST	13	P	Connect to 3.3 V host IO supply
VDDIO_GPIO	29	P	Connect to 3.3 V host IO supply or 1.8 V peripheral IO supply
Ground			
GND	–	P	Exposed ground pad (Mechanical Information)

3 Electrical Characteristics

3.1 Absolute maximum ratings

Absolute maximum ratings are those values beyond which damage to the device can occur. Functional operation under these conditions, or at any other condition beyond those indicated in this chapter, is not recommended.

[Table 3-1](#) summarizes the absolute maximum ratings for the QCA4004 device. [Table 3-2](#) shows the recommended operating conditions.

NOTE Maximum rating for signals follows the supply domain of the signals.

Table 3-1 Absolute maximum ratings

Symbol (Domain)	Description	Max rating	Unit
VDDIO_GPIO	I/O supply for GPIO15-GPIO31 pins	-0.3 to 4.0	V
VDDIO_HOST	I/O supply for GPIO0-GPIO13 pins	-0.3 to 4.0	V
DVDD12	Digital 1.2 V supply ¹	-0.3 to 1.32	V
SWREG_FB_VDD12			
VDD12_BB_PLL	1.2 V supply for analog BB PLL	-0.3 to 1.32	V
VDD12_RF	1.2 V supply for analog RF	-0.3 to 1.32	V
VDD12_SYNTH	1.2 V supply for analog SYNTH	-0.3 to 1.32	V
VDD33_ANT	Antenna control I/O supply	-0.3 to 4.0	V
VDD33_RF	3.3 V supply for analog RFs	-0.3 to 4.0	V
VDD33_SYNTH	3.3 V supply for analog SYNTH	-0.3 to 4.0	V
VDD33	3.3 V supply for switching regulator/PMU	-0.3 to 4.0	V
SWREG_IN			
VDD33_PLL_XTAL	3.3 V supply for XTAL/PLL	-0.3 to 4.0	V
VDD33_USB	3.3 V supply for USB	-0.3 to 4.0	V
V _{IH} MIN	Minimum Digital I/O Input Voltage for 1.8 V or 3.3 V I/O Supply	-0.3	V
3.3 V I/O V _{IH} MAX	Maximum Digital I/O Input Voltage for 3.3 V I/O Supply	V _{dd} +0.3	V
RF _{in}	Maximum RF input (reference to 50-Ω input)	+10	dBm
T _{store}	Storage Temperature	-45 to 135	°C
T _j	Junction Temperature	125	°C

1. DVDD12 and SWREG_FB are connected through an external LC filter to the SWREG_OUT pin. See [Figure 1-4](#).

3.2 Recommended operating conditions

Table 3-2 Recommended operating conditions

Symbol (Domain)	Parameter	Min	Typ	Max	Unit
VDDIO_GPIO	I/O supply for GPIO15-GPIO21 pins	1.71	–	3.46	V
VDDIO_HOST	I/O supply for GPIO0-GPIO13 pins	3.0	–	3.6	V
VBATT_3P3	I/O supply for GPIO31 pin	3.14	–	3.46	V
DVDD12	Digital 1.2 V supply ¹	1.20	1.26	1.32	V
SWREG_FB_VDD12					
VDD12_BB_PLL, VDD12_SYNTH, VDD12_RF	Analog 1.2 V supplies	1.20	1.26	1.32	V
VDD33	Internal switching regulator supply	3.14	3.3	3.46	V
SWREG_IN					
VDD33_ANT	Antenna control I/O supply	3.14	3.3	3.46	V
VDD33_RF, VDD33_SYNTH, VDD33_PLL_XTAL, VDD33_USB	Analog 3.3 V supplies	3.14	3.3	3.46	V
T _{case}	Standard case temperature	0	–	85	°C
	Industrial case temperature	-40	–	105	°C

1. DVDD12 and SWREG_FB_VDD12 are connected through an external LC filter to the SWREG_OUT pin. See [Figure 1-4](#).

3.3 Power sequencing

If a host processor controls the QCA4004 CHIP_PWD_L reset pin, then all supplies should be stable for a minimum of 5 μ S before CHIP_PWD_L is de-asserted (that is, is greater than V_{IL} for VDDIO_SDIO).

In the case where CHIP_PWD_L is not driven, but is a delayed version of VDD33 (power-on reset), the timing diagram in [Figure 3-1](#) applies.

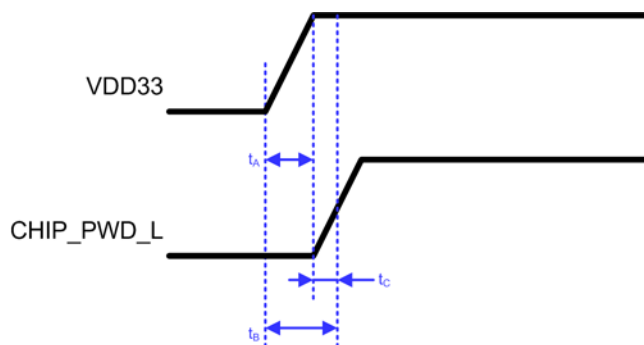


Figure 3-1 Power-On-Reset Timing

[Table 3-3](#) shows the values for timing for power on reset.

Table 3-3 Power-on-reset timing

Parameter	Description	Min	Max	Unit
t_A	Rise time of VDD33 to 90% of 3.3 V	—	25	mS
t_C	Time from VDD33 reaching 90% of 3.3 V to the level of CHIP_PWD_L going above $0.5 \times VDD33$	5	—	μ S
t_B	The value is $t_A + t_C$; during this time, the level of CHIP_PWD_L should stay below $0.5 \times VDD33$			

3.4 Digital logic characteristics

These conditions apply to all DC characteristics unless otherwise specified:

$$T_{amb} = 25\text{ }^{\circ}\text{C}, V_{dd33} = 3.3\text{ V}$$

Table 3-4 DC electrical characteristics for digital I/Os

Symbol	Parameter	Min	Typ	Max	Unit
V_{IH}	High Level Input Voltage	1.8	—	3.6	V
V_{IL}	Low Level Input Voltage	-0.3	—	0.3	V
V_{OH}	High Level Output Voltage	2.2	—	3.3	V
V_{OL}	Low Level Output Voltage	0	—	0.4	V
I_{IH}	High Level Input Current	—	—	0.1	μ A
I_{IL}	Low Level Input Current	—	—	0.1	μ A
I_{OH}	High Level Output Current for GPIO0 to GPIO13	—	—	20	mA
	High Level Output Current for GPIO15 to GPIO31	—	—	20	
I_{OL}	Low Level Output Current for GPIO0 to GPIO13	—	—	20	mA
	Low Level Output Current for GPIO15 to GPIO31	—	—	20	
C_{IN}	Input Capacitance for GPIO0 to GPIO13	—	5	—	pF
	Input Capacitance for GPIO15 to GPIO31	—	3	—	

3.5 Clock requirements

3.5.1 External reference clock timing

Figure 3-2 and Table 3-5 show the external 40 MHz reference input clock timing requirements.

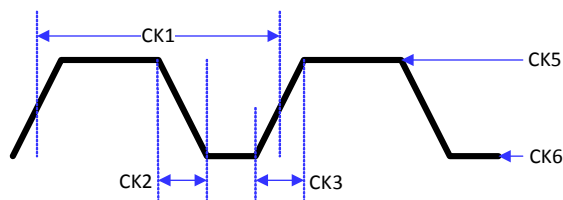


Figure 3-2 External reference input clock timing

Table 3-5 External 40 MHz reference input clock timing

Symbol	Description	Min	Typ	Max	Unit
CK1	Frequency accuracy	-20	–	20	ppm
	Frequency	–	40	–	MHz
CK2	Fall time	–	–	0.1 x period	ns
CK3	Rise time	–	–	0.1 x period	ns
CK4	Duty cycle (high-to-low ratio)	40	–	60	%
CK5	Input high voltage	0.75	–	1.26	V
CK6	Input low voltage	-0.55	–	0.3	V

3.5.2 SPI slave interface timing

Figure 3-3 shows the write timing for SPI slave style transactions.

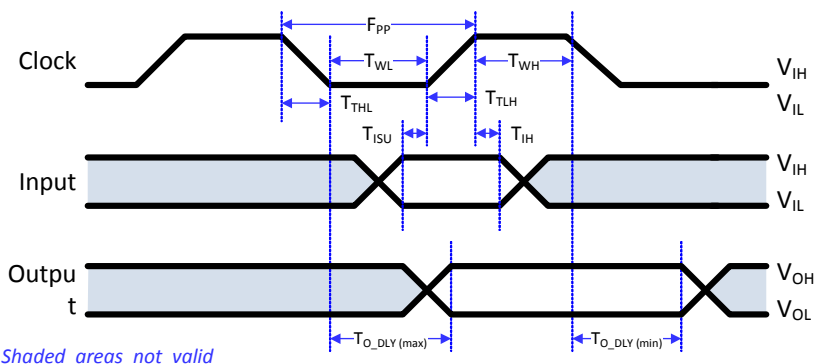


Figure 3-3 SPI slave timing

Table 3-6 shows the values for timing constraints for SPI slave.

Table 3-6 SPI slave timing constraints

Parameter	Description	Min	Max	Unit
f_{pp}	Clock frequency	0	48	MHz
t_{WL}	Clock low time	8.3	–	ns
t_{WH}	Clock high time	8.3	–	ns
t_{TLH}	Clock rise time	–	2	ns

Table 3-6 SPI slave timing constraints

Parameter	Description	Min	Max	Unit
t_{THL}	Clock fall time	–	2	ns
t_{ISU}	Input setup time	5	–	ns
t_{IH}	Input hold time	5	–	ns
t_{O_DLY}	Output delay	0	5	ns

3.5.3 SPI master interface timing

Figure 3-4 shows the write timing for SPI master style transactions.

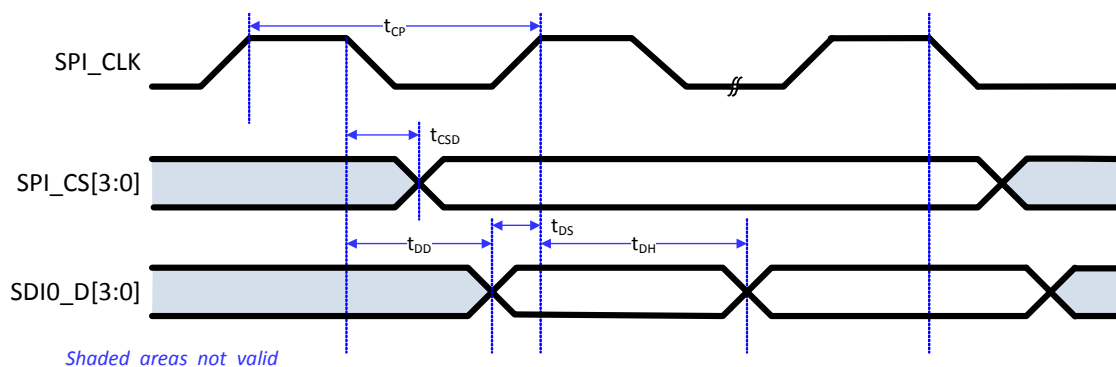
**Figure 3-4 SPI master timing**

Table 3-6 shows the values for timing constraints for SPI master.

Table 3-7 SPI master timing constraints

Parameter	Description	Min	Max	Unit
t_{CP}	Clock period	30.7	1000	ns
t_{CSD}	Chip select valid delay	-5.5	5	ns
t_{DD}	Data valid delay	-5.5	5	ns
t_{DS}	Data setup	3	–	ns
t_{DH}	Data hold	0	–	ns

4.1 Device physical dimensions

Figure 4-1 shows the QCA4004 device mechanical dimensions, top and bottom views.
(4004)

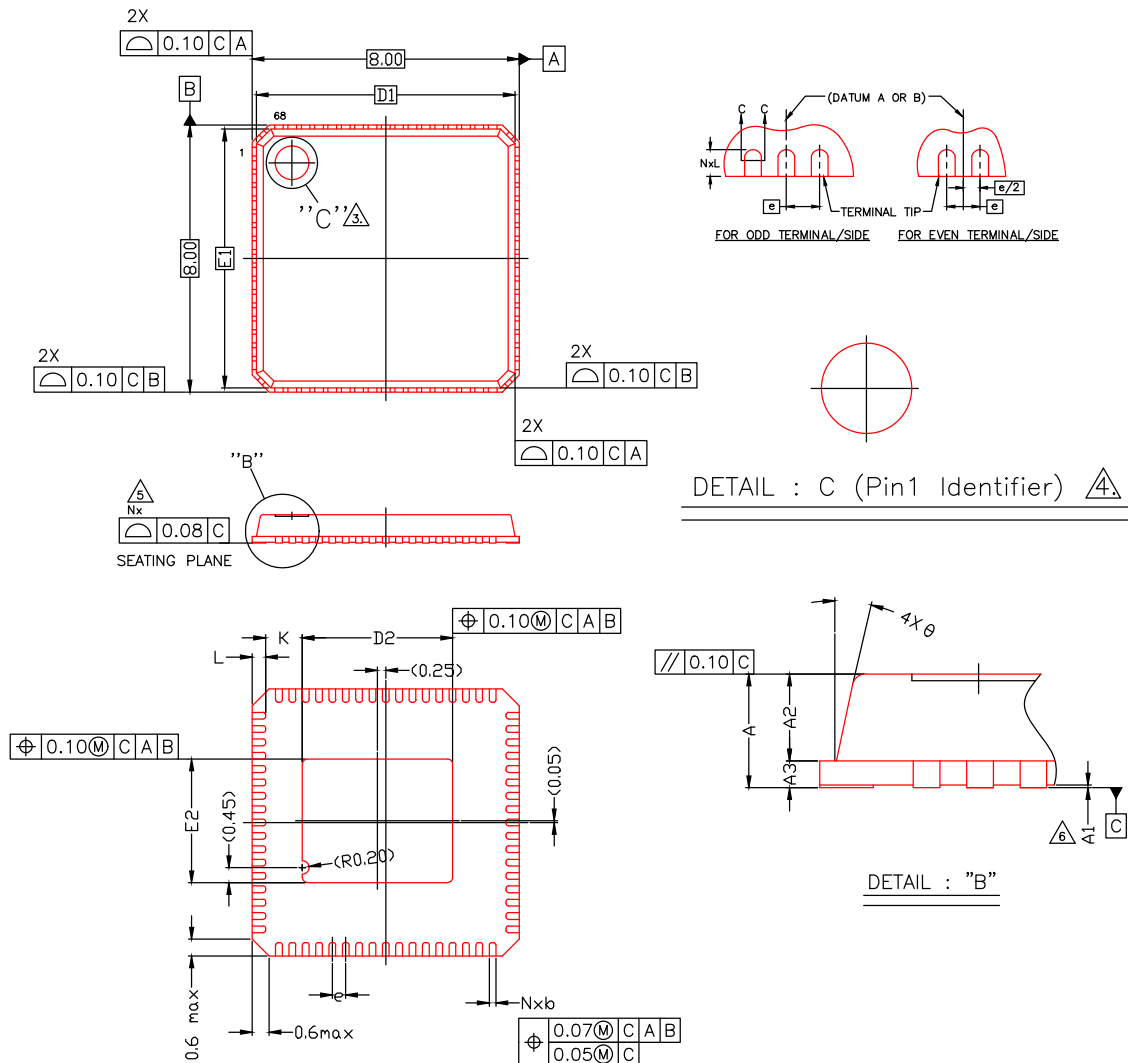


Figure 4-1 QCA4004 mechanical dimensions, top and bottom views

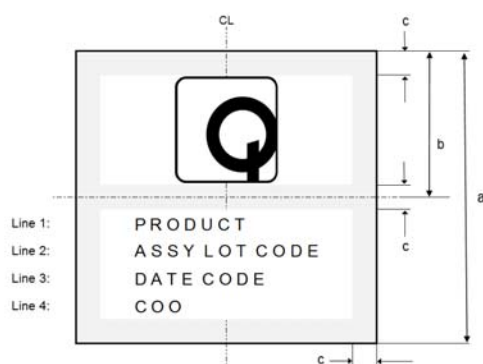
Table 4-1 Mechanical dimensions ¹

Dimension label	Min	Nom	Max	Unit
A	—	—	0.90	mm
A1	0.00	0.01	0.05	mm
A2	0.60	0.65	0.70	mm
A3	0.20 REF			mm
b	0.15	0.20	0.25	mm
L	0.30	0.40	0.50	mm
D1/E1	7.75 BSC			
D2	4.35	4.50	4.65	
E2	3.55	3.70	3.85	
e	0.40 BSC			mm
θ	0	—	14	°

1. Reference document: NT90-Y5242-1

4.2 Part marking

This device can be ordered using the identification code shown in [Section 4.3](#).

**Figure 4-2 Package marking layout****Table 4-2 Package marking identifiers**

Line	Marking
Line 1	QCA4004
Line 2	Assembly lot code
Line 3	Date code (YYWW)
Line 4	Country of origin (COO)

4.3 Device ordering information

QCA4004X-AL3A: a lead-free halogen-free standard-temperature version of the QCA4004.

QCA4004X-AL3B: a lead-free halogen-free industrial-temperature version of the QCA4004.

QCA4004X-BL3A: a lead-free halogen-free standard-temperature version of the QCA4004.

QCA4004X-BL3B: a lead-free halogen-free industrial-temperature version of the QCA4004.

4.4 Device moisture-sensitivity level

During device qualification, Qualcomm Atheros follows the latest revision IPC/JEDEC J-STD-020 standard to determine the IC's moisture-sensitivity level (MSL). See [Chapter 7](#) for more information.

To ensure proper SMT assembly, procedures must follow the MSL and maximum reflow temperature specified on the shipping bag labels or barcode labels accompanying all QCA4004 IC shipments.

Additional MSL information is included in:

- [Section 5.2](#) – Storage
- [Section 5.3](#) – Handling
- [Section 7.1](#) – Reliability qualifications summary
- *ASIC Packing Methods and Materials Specification (80-VK055-1)*

4.5 Thermal characteristics

Table 4-3 Device thermal resistance

Parameter	Comment	Typ	Unit
Ψ_{jT}	Thermal parameter	3	°C/W

5 Carrier, Storage, and Handling Information

5.1 Carrier

5.1.1 Tape and reel information

Carrier tape system conforms to the EIA-481 standard.

Simplified sketches of the QCA4004 tape carrier is shown in [Figure 5-1](#) and [Figure 5-2](#), including the part orientation. Tape and reel details for the QCA4004 are as follows:

- Reel diameter: 330 mm
- Hub size: 102 mm
- Tape width: 16 mm
- Tape pocket pitch: 12 mm
- Feed: Single
- Units per reel: 4,000

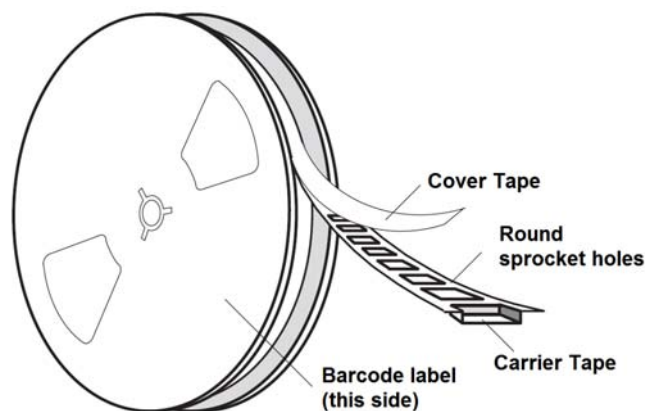


Figure 5-1 Tape orientation on reel

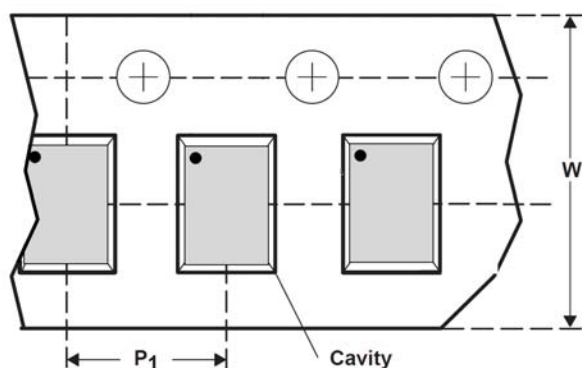


Figure 5-2 Part orientation in tape

5.1.2 Matrix tray information

All Qualcomm Atheros matrix tray carriers conform to JEDEC standards. The device pin 1 is oriented to the chamfered corner of the matrix tray. Each tray of the QCA4004 device contains up to 260 devices. See [Figure 5-3](#) for matrix-tray key attributes and dimensions.

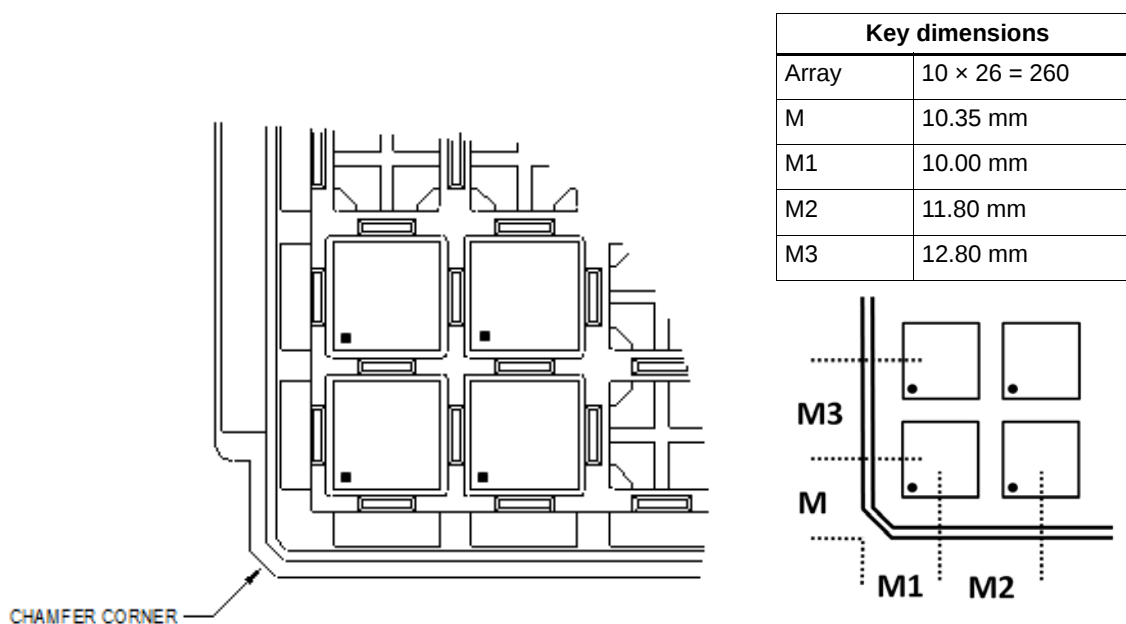


Figure 5-3 Matrix tray part orientation

5.2 Storage

5.2.1 Bag storage conditions

The packages described in this document must be stored in a nitrogen-purged, sealed moisture barrier antistatic bag. The Qualcomm-calculated shelf life in a sealed moisture bag is 60 months at < 40°C and < 90% relative humidity (RH).

5.2.2 Out of bag duration

After unpacking, the package must be soldered to the PCB within the factory floor life according to the MSL rating when factory conditions are < 30°C and < 60% RH, as specified in the IPC/JEDEC-STD-033 standard.

5.3 Handling

Tape handling was described in [Section 5.1.1](#). Other handling guidelines are presented below.

5.3.1 Baking

It is not necessary to bake the QCA4004 if the conditions specified in [Section 5.2.1](#) and [Section 5.2.2](#) have not been exceeded.

It is necessary to bake the QCA4004 if any condition specified in [Section 5.2.1](#) or [Section 5.2.2](#) has been exceeded. The baking conditions are specified on the moisture-sensitive caution label attached to each bag. See *ASIC Packing Methods and Materials Specification* (80-VK055-1) for details.

CAUTION If baking is required, the devices must be transferred into trays that can be baked to at least 125°C. Devices should not be baked in tape and reel carriers at any temperature.

5.3.2 Electrostatic discharge

Electrostatic discharge (ESD) occurs naturally in laboratory and factory environments. An established high-voltage potential is always at risk of discharging to a lower potential. If this discharge path is through a semiconductor device, destructive damage may result.

ESD countermeasures and handling methods must be developed and used to control the factory environment at each manufacturing site.

Qualcomm products must be handled according to the ESD Association standard: *ANSI/ESD S20.20-1999, Protection of Electrical and Electronic Parts, Assemblies, and Equipment*.

5.4 Barcode label and packing for shipment

Refer to the *ASIC Packing and Materials Specification* (80-VK055-1) document for all packing-related information, including barcode label details.

6 PCB Mounting Guidelines

Guidelines for mounting the QCA4004 device onto a PCB are presented in this chapter, including land pad and stencil design details, surface mount technology (SMT) process characterization, and SMT process verification.

6.1 RoHS compliance

The device is externally lead-free and RoHS-compliant. Qualcomm Atheros defines its lead-free (or Pb-free) semiconductor products as having a maximum lead concentration of 1000 ppm (0.1% by weight) in raw (homogeneous) materials and end products. Qualcomm Atheros package environmental programs, RoHS compliance details, and tables defining pertinent characteristics of all Qualcomm Atheros IC products are described in the *IC Package Environmental Roadmap* (80-V6921-1).

6.2 SMT parameters

The information presented in this section describes Qualcomm Atheros board-level characterization process parameters. It is included to assist customers when starting their SMT process development; it is not intended to be a specification for customer SMT processes.

NOTE Qualcomm Atheros recommends that customers follow their solder paste vendor recommendations for the screen-printing process parameters and reflow profile conditions.

Qualcomm Atheros characterization tests attempt to optimize the SMT process for the best board-level reliability possible. This is done by performing physical tests on evaluation boards, which may include:

- Drop shock
- Temperature cycling
- Bend cycle (optional)

6.2.1 Land pad and stencil design

Qualcomm Atheros recommends characterizing the land patterns according to each customer's processes, materials, equipment, stencil design, and reflow profile **prior to PCB production**. Optimizing the solder stencil-pattern design and print process is critical to ensure print uniformity,

decrease voiding, and increase board-level reliability. See *PCB Land and Stencil Design Guide* (LS90-NG134-1) for characterization.

6.2.2 Reflow profile

Reflow profile conditions typically used by Qualcomm Atheros for SnPb and lead-free systems are given in [Table 6-1](#).

Table 6-1 Qualcomm Atheros typical SMT reflow profile conditions (for reference only)

Profile stage	Description	Temp range	Lead-free (high temperature condition limits)
Preheat	Initial ramp	< 150°C	3°C/sec max
Soak	Dry out and flux activation	150 to 190°C	60 to 120 sec
Ramp	Transition to liquidus (solder-paste melting point)	190 to 220°C	< 30 sec
Reflow	Time above liquidus	220 to 245°C ¹	50 to 70 sec
Cool down	Cool rate – ramp-to-ambient	< 220°C	6°C/sec max

1. During the reflow state, the peak temperature should not exceed 245°C. This temperature should not be confused with the peak temperature reached during MSL testing.

[Figure 6-1](#) shows the typical SMT reflow profile.

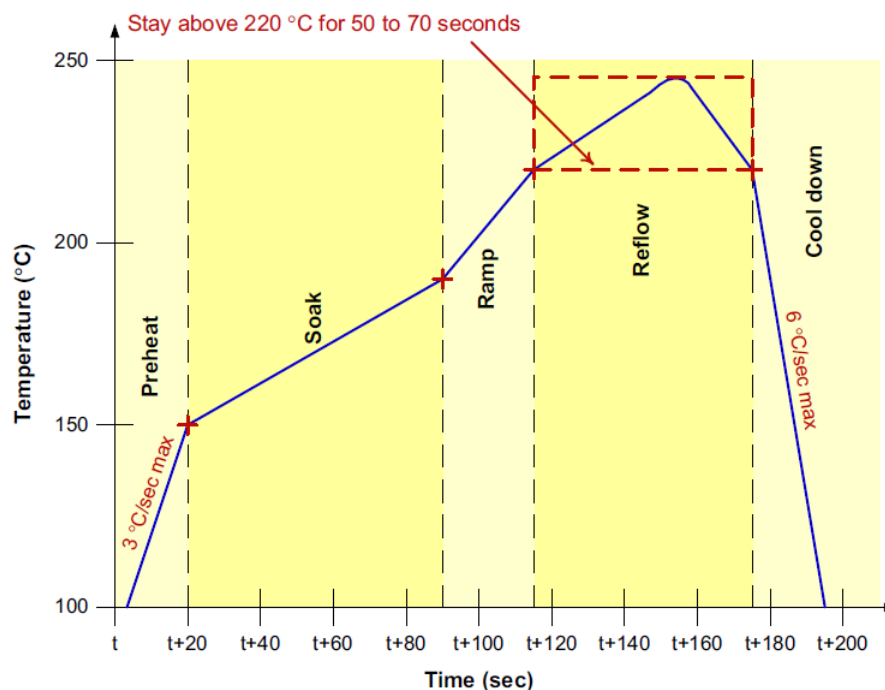


Figure 6-1 Typical SMT reflow profile

6.2.3 SMT peak package-body temperature

During a production board's reflow process, the temperature for the package must be controlled. The recommended peak temperature during production assembly is 245°C. This is comfortably above the solder melting point (220°C), yet well below the proven temperature reached during qualification (255°C or more).

Although the solder-paste manufacturer's recommendations for optimum temperature and duration for solder reflow must be followed, the Qualcomm Atheros recommended limits must not be exceeded.

6.2.4 SMT process verification

Qualcomm Atheros recommends verification of the SMT process prior to high-volume PCB fabrication, including:

- Electrical continuity
- X-ray inspection of the package installation for proper alignment, solder voids, solder balls, and solder bridging
- Visual inspection
- Cross-section inspection of solder joints to confirm registration, fillet shape, and print volume

6.3 Board-level reliability

Qualcomm Atheros conducts characterization tests to assess the device's board-level reliability, including the following physical tests on evaluation boards:

- Drop shock (JESD22-B111)
- Temperature cycling (JESD22-A104)
- (Optional) Cyclic bend testing (JESD22-B113)

See *Board-level Reliability* (BR80-NT096-1) for details.

7 Part Reliability

7.1 Reliability qualifications summary

Table 7-1 QCA4004 reliability evaluation

Reliability tests, standards, and conditions	Sample # Lots	Result	Assembly1	Assembly2
Average failure rate (AFR) in FIT (λ) Failure in billion device-hours Functional HTOL: JESD22-A108	231 3 lots	$\lambda = 20$ FIT	–	–
ESD – (HBM) human body model rating JESD22-A114-B	3	Pass ± 2000 V, all pins	–	–
ESD – (CDM) charge device model rating JESD22-C101-C	3	Pass ± 500 V, all pins except RFIN2P1 and RFIN2N1 pass ± 400 V	–	–
Latch-up (Overcurrent test): EIA/JESD78 Trigger current: ± 200 mA; temperature: 25°C	6 1 lot	Pass	–	–
Latch-up (Overvoltage test): EIA/JESD78 Trigger voltage: $1.6 \times V_{\text{nom}}$; temperature: 25°C	6 1 lot	Pass	–	–
High Temperature Storage Life (HTSL) JESD-22 A104, -50 to $+150^{\circ}\text{C}$, 1000 hrs	462 3 + 3 lots	–	Pass	Pass
Moisture/Reflow Sensitivity Classification: MSL3; JSTD-020D, (30C/60% RH, 192 hrs, 3 x IR @ 260°C)	1078 3 + 3 lots	–	Pass	Pass
Temperature cycle: JESD22-A104 Temperature: -65 to $+150^{\circ}\text{C}$ Number of cycles: 1000 Min soak time at min/max temperature: 5 minutes Cycle rate: 2 cycles per hour (cph) Prerequisite: All samples subjected to preconditioning MSL 3 and reflow (260°C) 3X prior to TC	462 3 + 3 lots	–	Pass	Pass
Highly accelerated stress test, unbiased (HAST) JESD22-A118 Prerequisite: All samples subjected to preconditioning MSL 3 and reflow (260°C) 3X prior to HAST	474 3 + 3 lots	–	Pass	Pass

Table 7-1 QCA4004 reliability evaluation

Reliability tests, standards, and conditions	Sample # Lots	Result	Assembly1	Assembly2
Highly accelerated stress test, biased (bHAST) JESD22-A118 Prerequisite: All samples subjected to preconditioning MSL 3 and reflow (260°C) 3X prior to HAST	158 1 + 1 lots	–	Pass	Pass
Die shear (5 kg)	5	–	Pass	Pass

7.2 Qualification sample description

- Device name: QCA4004
- Package type: QFN 68L
- Package body size: 8 mm × 8 mm × 0.85 mm
- Lead count: 68
- Lead pitch: 0.4 mm